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Brian N. Figgis* and Alexandre N. Sobolev

Chemistry, M313, School of Biomedical and Chemical Sciences, University of Western Australia, 35 Stirling Highway, Crawley, WA 6009, Australia

Correspondence e-mail: bnf@theochem.uwa.edu.au

Key indicators

Single-crystal X-ray study T = 11 K Mean σ (O–C) = 0.001 Å R factor = 0.020 wR factor = 0.054 Data-to-parameter ratio = 61.9

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

Hexacarbonylchromium(0) at 11 K

The crystal structure of hexacarbonylchromium(0), $[Cr(CO)_6]$, has been refined with an accurate and extensive X-ray data set collected at 11 K. This data set should be suitable for charge-density analysis studies. The structure is made up of isolated $Cr(CO)_6$ molecules of very near octahedral symmetry, containing a crystallographic mirror plane.

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Comment

 $Cr(CO)_6$, (I), has long been of interest in inorganic chemistry as it is an archetypal transition metal carbonyl complex. Its room-temperature structure was determined by Whitaker & Jeffery (1967) and an X–N charge-density study was carried out at 74 K (Rees & Mitschler, 1976).

The cell parameters, bond lengths and angles for the $Cr(CO)_6$ molecule at various temperatures are given in Table 1.

The structure consists of isolated $Cr(CO)_6$ molecules. Each molecule comprises a near-regular octahedron. There is a plane containing two pairs of CO groups related by crystallographic mirror symmetry and with C-Cr-C angles within 1° of a right angle. The relevant Cr-C bond lengths differ by only 0.005 Å. Above and below this plane are two CO groups within 0.5° of a right angle and which differ in distance only slightly (0.005 Å) and match those in the plane within the same amount, the overall average being 1.916 Å. The Cr-C-O angles are all within 1° of being linear, and the C-O bond lengths all lie within 0.002 Å of the average of 1.142 Å.

The atomic displacement parameters decrease with temperature, largely as expected.

Experimental

In a sealed glass tube, $Cr(CO)_6$ (Aldrich) was sublimed over a temperature gradient of *ca* 1 K mm⁻¹ for a period of 1 d. The very low temperature data sets were collected on a locally assembled Huber 512 goniometer equipped with a Displex 202D cryogenic refrigerator (Henriksen *et al.*, 1986; Larsen, 1995). A full sphere of data was collected. The correction for the absorption by the beryllium thermal shields was calculated by the *PROFIT* (Streltsov & Zavodnik, 1989) program.

Crystal data [Cr(CO)₆] $M_r = 220.06$ Orthorhombic, *Pnma* a = 11.474 (1) Å b = 10.894 (1) Å

c = 6.1885 (4) Å

Z = 4

 $V = 773.55 (11) \text{ Å}^3$

 $D_x = 1.890 \text{ Mg m}^{-3}$

Mo K α radiation Cell parameters from 14 reflections $\theta = 31.4-38.7^{\circ}$ $\mu = 1.47 \text{ mm}^{-1}$ T = 11.0 (5) KPrism, pale yellow $0.46 \times 0.40 \times 0.40 \text{ mm}$

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Data collection

Huber 512 goniometer diffractometer
ω –2 θ scans
Absorption correction: Gaussian
(Xtal3.7; Hall et al., 2000)
$T_{\min} = 0.564, \ T_{\max} = 0.639$
27 649 measured reflections
4212 independent reflections
4125 reflections with $I > 2\sigma(I)$

Refinement

Refinement on F^2
$R[F^2 > 2\sigma(F^2)] = 0.020$
$wR(F^2) = 0.054$
S = 1.14
4212 reflections
68 parameters

 $\begin{aligned} R_{\rm int} &= 0.023\\ \theta_{\rm max} &= 50.1^\circ\\ h &= -24 \rightarrow 24\\ k &= -23 \rightarrow 23\\ l &= -13 \rightarrow 13\\ 3 \text{ standard reflections}\\ \text{every 100 reflections}\\ \text{intensity decay: }1\% \end{aligned}$

$$\begin{split} w &= 1/[\sigma^2(F_o^2) + (0.0244P)^2 \\ &+ 0.21P] \\ \text{where } P &= (F_o^2 + 2F_c^2)/3 \\ (\Delta/\sigma)_{\text{max}} &= 0.001 \\ \Delta\rho_{\text{max}} &= 0.84 \text{ e } \text{\AA}^{-3} \\ \Delta\rho_{\text{min}} &= -1.00 \text{ e } \text{\AA}^{-3} \\ \text{Extinction correction: SHELXL97} \\ \text{Extinction coefficient: } 0.069 (2) \end{split}$$

Table 1

Cell parameters (Å, Å³), bond lengths (Å) and angles (°) in the Cr(CO)₆ molecule at various temperatures (K) by X-ray {X} and neutron {N} diffraction.

Cell parameters	293{X} ^a	$74{X}^{b}$	78{N} ^c	$11\{\mathbf{X}\}^d$
a	11.769 (12)	11.505 (4)	11.490 (15)	11.474 (1)
b	11.092 (11)	10.916 (3)	10.905 (13)	10.894 (1)
с	6.332 (6)	6.203 (2)	6.197 (14)	6.1885 (4)
V	826.6 (24)	779.0 (7)	776.5 (37)	773.55 (11)
Cr-C1	1.891 (7)	1.912 (2)	1.913 (2)	1.9121 (5)
Cr-C2	1.928 (7)	1.916 (2)	1.911 (2)	1.9171 (5)
Cr-C3	1.910 (4)	1.915 (1)	1.913 (1)	1.9152 (4)
Cr-C4	1.909 (4)	1.918(1)	1.919(1)	1.9201 (4)
C1-O1	1.151 (8)	1.143 (3)	1.140(1)	1.1432 (7)
C2-O2	1.109 (8)	1.141 (3)	1.141 (1)	1.1421 (7)
C3-O3	1.137 (6)	1.139 (2)	1.141 (1)	1.1412 (5)
C4-O4	1.143 (6)	1.138 (2)	1.138 (1)	1.1399 (5)
Cr-C1-O1	179.6 (6)	179.9 (2)	180.0 (1)	179.94 (5)
Cr-C2-O2	178.8 (6)	179.1 (2)	179.5 (1)	179.45 (5)
Cr-C3-O3	178.3 (4)	179.4 (2)	179.37 (8)	179.38 (4)
Cr-C4-O4	178.5 (4)	179.2 (1)	179.10(7)	179.19 (3)
C1-Cr-C2	178.9 (3)	179.6 (1)	179.4 (1)	179.45 (2)
C1-Cr-C3	90.0 (2)	90.37 (6)	90.34 (6)	90.36 (2)
C1-Cr-C4	89.8 (3)	90.14 (7)	89.96 (6)	90.09 (2)
C2-Cr-C3	90.7 (2)	89.94 (6)	90.06 (6)	90.03 (2)
C2-Cr-C4	89.4 (2)	89.55 (6)	89.65 (6)	89.53 (2)
C3-Cr-C3 ⁱ	89.5 (3)	89.40 (8)	89.53 (8)	89.54 (2)
C3-Cr-C4	89.5 (2)	89.85 (5)	89.79 (3)	89.79 (2)
C3-Cr-C4 ⁱ	179.3 (3)	179.10 (6)	179.26 (8)	179.20 (2)
C4-Cr-C4 ⁱ	90.8 (3)	90.89 (8)	90.89 (8)	90.88 (2)

References: (a) Whitaker & Jeffery (1967); (b) Rees & Mitschler (1976); (c) Jost *et al.* (1975); (d) this work. Symmetry code: (i) $x, \frac{1}{2} - y, z$.



Figure 1

The Cr(CO)₆ molecule at 11 K. Displacement ellipsoids are drawn at the 50% probability level. [Symmetry code: (i) $x, \frac{1}{2} - y, z$.]

Data collection: Local diffractometer control software; cell refinement: Local diffractometer control software; data reduction: *PROFIT* (Streltsov & Zavodnik, 1989); program(s) used to solve structure: *SHELXTL* (Bruker, 1997); program(s) used to refine structure: *SHELXTL*; molecular graphics: *SHELXTL*; software used to prepare material for publication: *SHELXTL*.

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